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INFORMATION DISCLOSURE

STATEMENT BY APPLICANT

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SERIAL NO 09/096,164

APPLICANT Duanfeng He et al.

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	AC	5	5	1	4	8	5	8	05/07/1996	Ackley	235	462	02/10/1995	
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	ΑE	5	4	4	9	8	9	3	09/12/1995	Bridgelall et al.	235	462	11/30/1994	
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	AG	5	3	2	9	1	0	5	07/12/1994	Klancnik et al.	235	463	08/10/1992	
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## FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

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EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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